

10/18/07

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 279585US0X PCT		SERIAL NO. 10/554,218	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Katsuya OKUMURA, et al.			
				FILING DATE October 24, 2005		GROUP 1634	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/NB/	AA	US 2001/0019029 A1	9/6/2001	Yu-Chong TAI, et al.			
/NB/	AB	5,753,014	5/19/1998	Cornelis Johannes Maria Van RIJN			
	AC						
	AD						
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	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/NB/	AO	EP 1 471 991 B1	6/21/2006	Europe			
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
/NB/	AW	Xing YANG et al. "Micromachined membrane particle filters" Sensors and Actuators 73 (1999) pages 184-191.					
/NB/	AX	Cees van RIJN et al. "Deflection and Maximum Load of Microfiltration Membrane Sieves Made with Silicon Micromachining" Journal of Microelectromechanical Systems VOL. 6 NO. 1. March 1997, pages 48-54					
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Narayan Bhat/		Date Considered 11/27/2007	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

4/2/07

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 279585US0X PCT		SERIAL NO. 10/554,218	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Katsuya OKUMURA, et al.			
				FILING DATE October 24, 2005		GROUP 1645 1634	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL /NB/		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	6,738,330	04/07/1998	R. Jerrold FULTON			
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/NB/	AH	57-168163	10/16/1982	Japan (with English abstract)			X
	AI	62-81568	04/15/1987	Japan (with English abstract)			X
	AJ	63-27000	02/04/1988	Japan (with English abstract)			X
	AK	10-83902	03/31/1998	Japan (with English abstract)			X
	AL	11-176622	07/02/1999	Japan (with English abstract)			X
	AM	11-243997	09/14/1999	Japan (with English abstract)			X
	AN	2000-181074	06/30/2000	Japan (with English abstract)			X
	AO	2000-258650	09/22/2000	Japan (with English abstract)			X
	AP	2000-346842	12/15/2000	Japan (with English abstract)			X
	AQ	2003-11099	01/15/2003	Japan (with English abstract)			X
	AR	7-54324	06/07/1995	Japan (with English abstract of corr. EP 0 126 450)			X
	AS	2975603	09/03/1999	Japan (with corr. EP 0 328 829 A2)			X
	AT	0 328 829 A2	08/23/1989	Europe			
	AU	WO 01/12846 A1	02/22/2001	WIPO			
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
/NB/	AW	M. ABE, "Ferri-Film Formation from an Aqueous Solution, and its Applications", JOURNAL OF THE MAGNETICS SOCIETY OF JAPAN, Vol. 22, No. 9, 1988, cover page, pages 1225-1232 and 1288 (with partial English translation).					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Narayan Bhat/		Date Considered 11/27/2007	
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10/554218

JC09 Rec'd PCT/PTO 24 OCT 2005

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 279585US0X PCT		SERIAL NO. New U.S. PCT Application Based on PCT/JP04/05878	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Katsuya OKUMURA, et al.			
				FILING DATE Herewith		GROUP 1634	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
/NB/	AO	2003-014760	01/15/03	JP(English abstract only)		NO	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Narayan Bhat/		Date Considered 11/27/2007	
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